



## Quality Control and Product Monitoring in Manufacturing

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### Message from the Guest Editors

Quality control and product monitoring play integral roles in modern manufacturing, ensuring consistent product quality, customer satisfaction, and regulatory adherence. This proposal outlines our intent to contribute to a special journal issue focused on these crucial aspects of manufacturing.

Quality control encompasses systematic processes like statistical process control and Six Sigma methodologies. Product monitoring extends beyond the factory floor, involving real-time data collection and analysis using technologies such as IoT sensors, machine learning, and data analytics. These tools enable manufacturers to detect anomalies swiftly, improving product quality reducing waste and costs. In this Special Issue, we aim to explore recent advancements, best practices, and case studies in quality control and product monitoring across various manufacturing sectors. We will highlight how emerging technologies, data-driven insights, and collaborative strategies are reshaping these vital aspects of manufacturing, fostering innovation, sustainability, and global competitiveness.





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## Message from the Editor-in-Chief

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